


Search Notes 	Application/Control No. 10782231	Applicant(s)/Patent Under Reexamination MOELLER ET AL.
	Examiner Kim, David S	Art Unit 2613

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
reviewed references in U.S. Patent Application No. 10/730,413	12/22/2006	DSK
EAST search - see search history printout	12/22/2006	DSK
www.google.com - search terms: or gate nand	12/22/2006	DSK
EAST search - see search history printout	10/15/2007	DSK
www.google.com - various combinations of the following terms: NRZ pulse broadening widens dispersion eye diagram -spm	10/15/2007	DSK
scholar.google.com - various combinations of the following terms: NRZ pulse broadening widens broaden widen	10/15/2007	DSK
EAST search - see search history printout	12/19, 12/20/2008	DSK
www.google.com - various combinations of the following terms: duobinary waveform NRZ RZ "sampling window" "sampling point"	12/19, 12/20/2008	DSK
scholar.google.com - various combinations of the following terms: duobinary duty cycle 100 NRZ waveform RZ "sampling window" "sampling point" eye integrating window diagram narrow integration sampling	12/19, 12/20/2008	DSK

INTERFERENCE SEARCH			
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